

**Search Notes**

Application/Control No.

10/530,524

Examiner

Chris H. Chu

Applicant(s)/Patent under  
Reexamination

STEVENS ET AL.

Art Unit

2874

**SEARCHED**

Class	Subclass	Date	Examiner
356	480	12/21/2006	CC
385	12	12/21/2006	CC
374	161	12/21/2006	CC

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
applicant's cited references	12/21/2006	CC
text search	12/21/2006	CC